


<b>Search Notes</b>  	<b>Application/Control No.</b>  10555286	<b>Applicant(s)/Patent Under Reexamination</b>  JIMENEZ MAYORGA ET AL.
	<b>Examiner</b>  SUN JAE Y LOEWE	<b>Art Unit</b>  1626

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
restriction requirement	5-26-2008	sl
STN: registry & caplus	7-11-2008	sl
PALM all inventors	7-11-2008	sl

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner